

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 19.0004

CB Certificate No.: 50600284 ITL

Schedule Number: IECQ-L ULTW 19.0004-S Rev No.: 3 Revision Date: 2021/06/16 Page 1 of 1

Appendix-1 (50600284 ITL) Schedule of Scope to Certificate of Approval

Description test	Standard
Dew (DEW)	JEDEC JESD22-A100D
Temperature and Humidity with Bias (THB)	JEDEC JESD22-A101D
Wet High Temperature Operating Life (WHTOL)	JEDEC JESD22-A101D
High Humidity High Temperature Reverse Bias (H ³ TRB)	JEDEC JESD22-A101D
Temperature Cycling (TC)	JEDEC JESD22-A104E, IEC 60068-2-14 Nb
High Temperature Operation Life (HTOL)	JEDEC JESD22-A108F
Low Temperature Operating Life (LTOL)	JEDEC JESD22-A108F
High Temperature Reverse Bias (HTRB)	JEDEC JESD22-A108F
Pulsed Operating Life (PLT)	JEDEC JESD22-A108F

Technical Reviewer of DQS: Michael Chou Date: 6/16/2021

